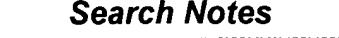


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/708,417	WANG ET AL.
	Examiner	Art Unit
	Ninh H. Nguyen	3745

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner